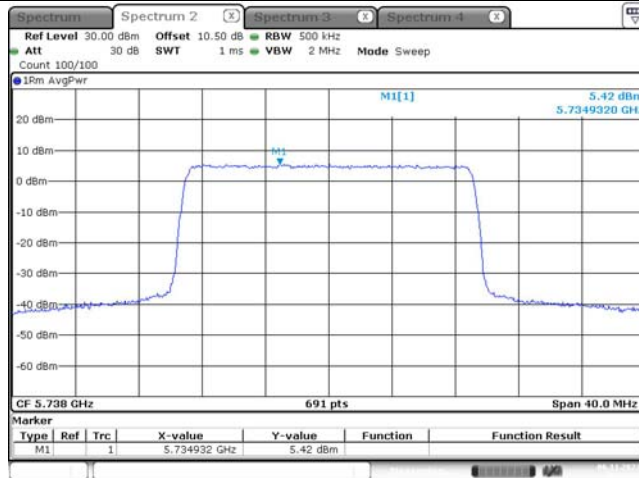
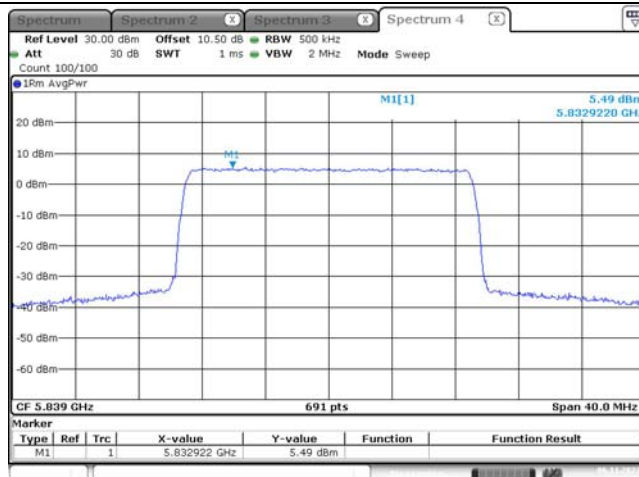
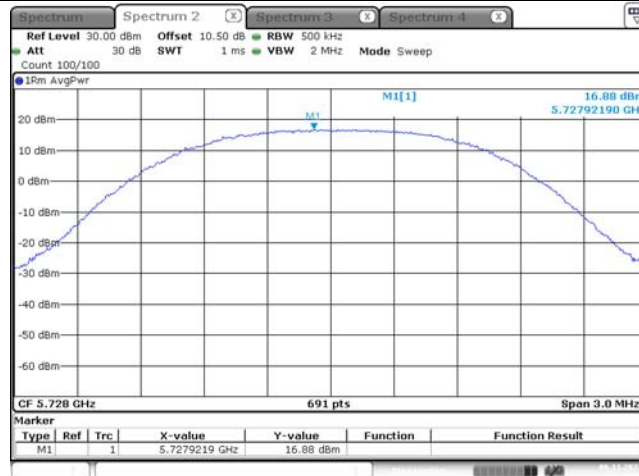
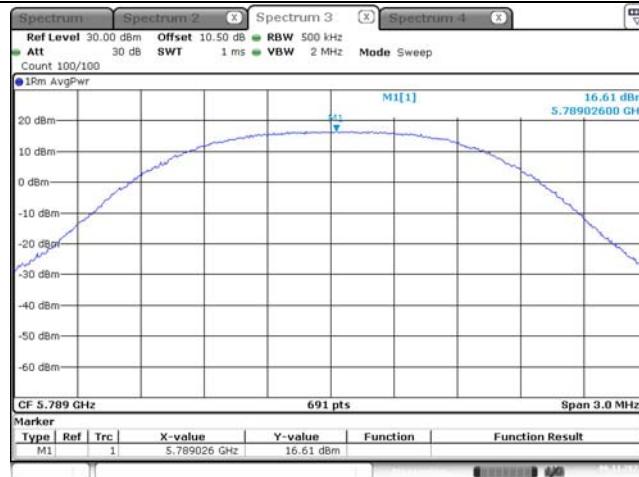
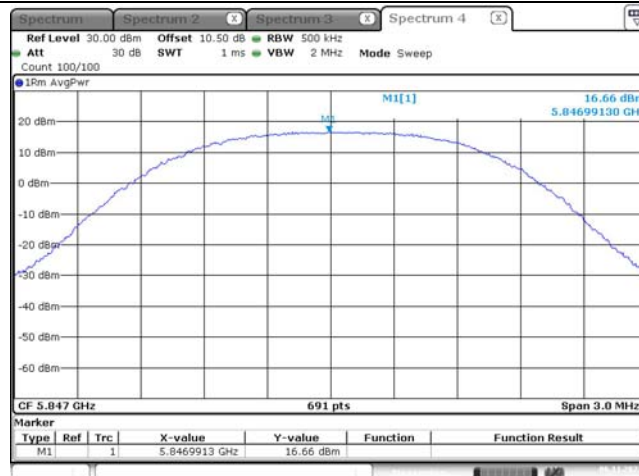


Maximum power spectral density

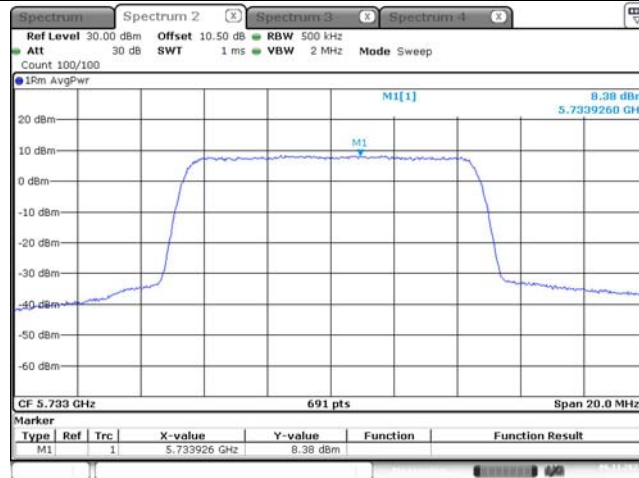
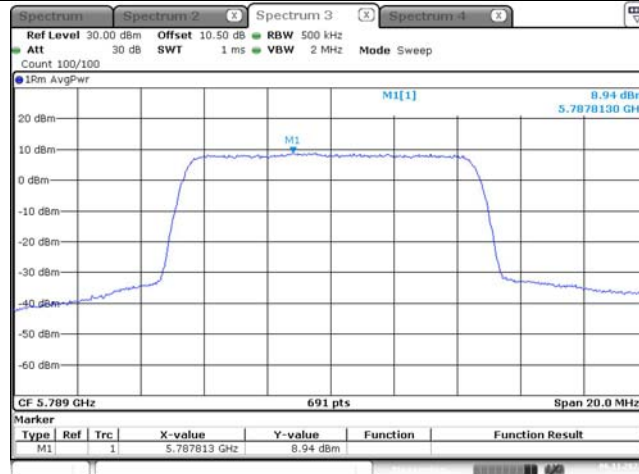
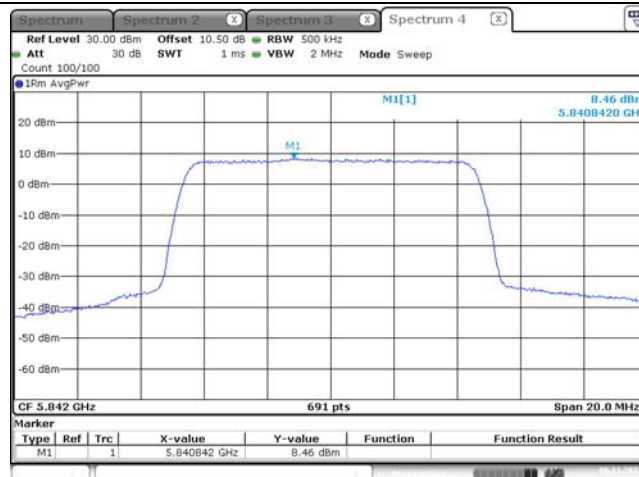
16QAM,20M
Lowest ChannelProjectNo.:CR230955603 Tester:Jin Wei
Date: 6.NOV.2023 16:52:2316QAM,20M
Middle ChannelProjectNo.:CR230955603 Tester:Jin Wei
Date: 6.NOV.2023 16:51:2316QAM,20M
Highest ChannelProjectNo.:CR230955603 Tester:Jin Wei
Date: 6.NOV.2023 16:48:36

Chain 2:

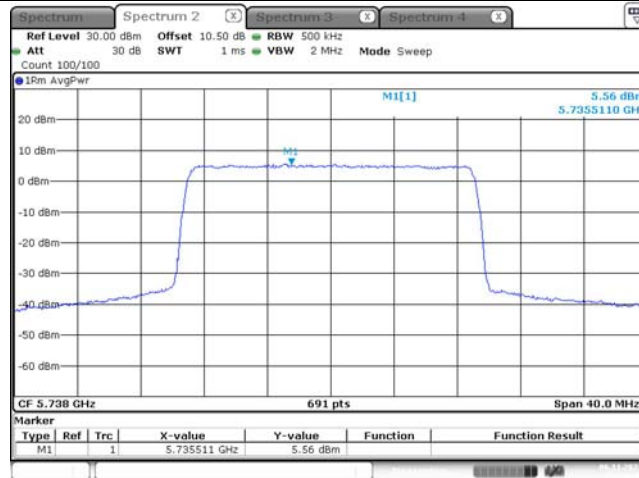
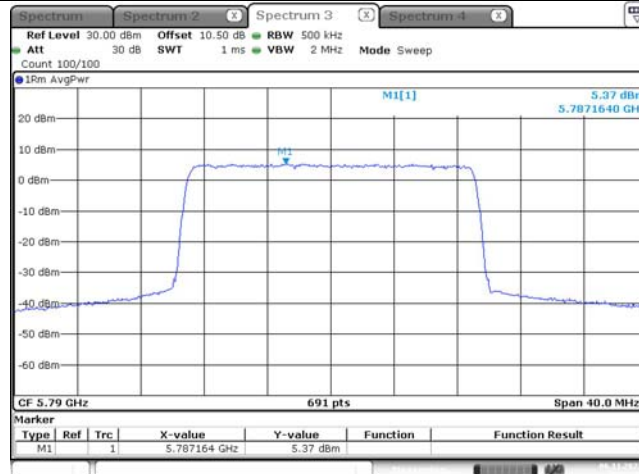
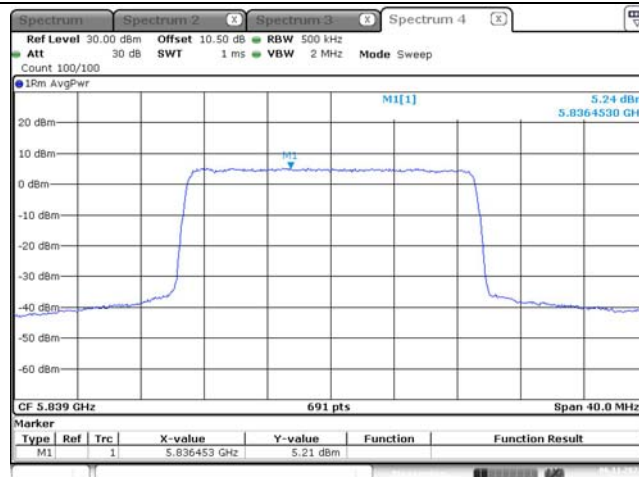
Maximum power spectral density

QPSK,1.4M
Lowest ChannelProjectNo.:CR230955603 Tester:Jim Wei
Date: 6.NOV.2023 14:44:19QPSK,1.4M
Middle ChannelProjectNo.:CR230955603 Tester:Jim Wei
Date: 6.NOV.2023 14:45:57QPSK,1.4M
Highest ChannelProjectNo.:CR230955603 Tester:Jim Wei
Date: 6.NOV.2023 14:48:01

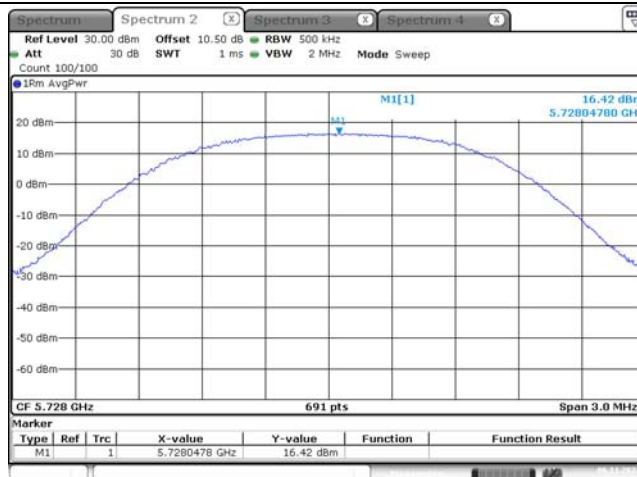
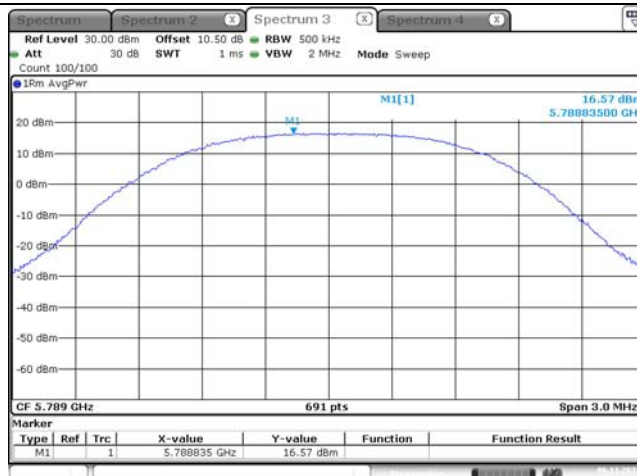
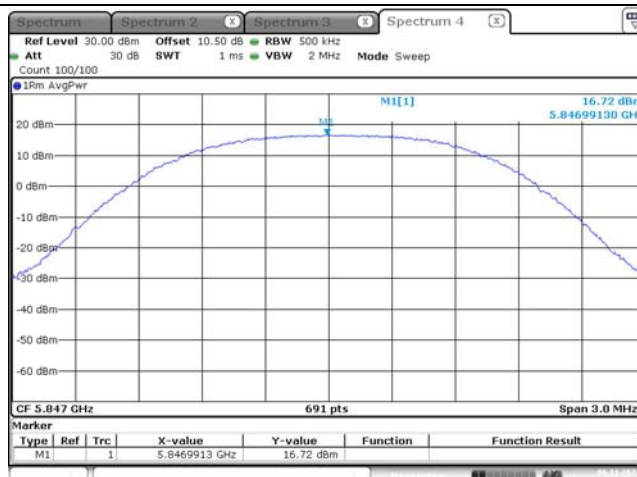
Maximum power spectral density

QPSK,10M
Lowest ChannelProjectNo.:CR230955603 Tester:Jin Wei
Date: 6.NOV.2023 14:54:48QPSK,10M
Middle ChannelProjectNo.:CR230955603 Tester:Jin Wei
Date: 6.NOV.2023 14:53:13QPSK,10M
Highest ChannelProjectNo.:CR230955603 Tester:Jin Wei
Date: 6.NOV.2023 14:52:22

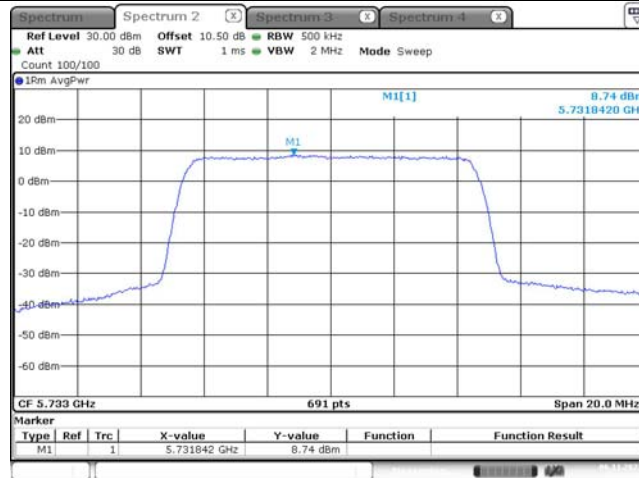
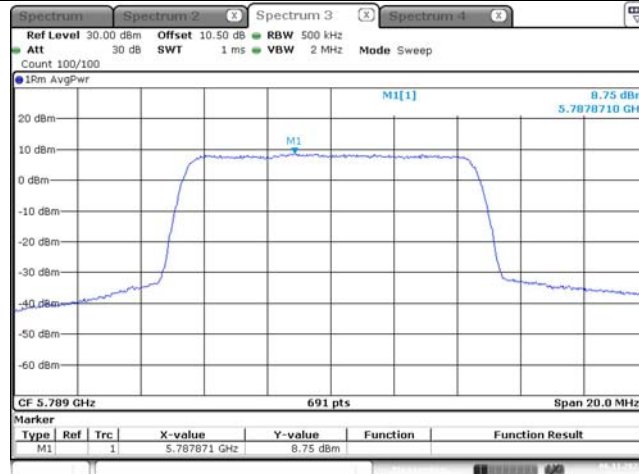
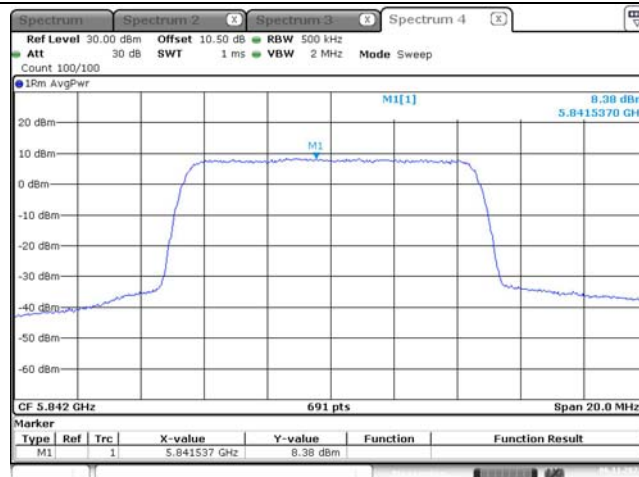
Maximum power spectral density

QPSK,20M
Lowest ChannelProjectNo.:CR230955603 Tester:Jin Wei
Date: 6.NOV.2023 14:58:43QPSK,20M
Middle ChannelProjectNo.:CR230955603 Tester:Jin Wei
Date: 6.NOV.2023 15:00:30QPSK,20M
Highest ChannelProjectNo.:CR230955603 Tester:Jin Wei
Date: 6.NOV.2023 15:01:23

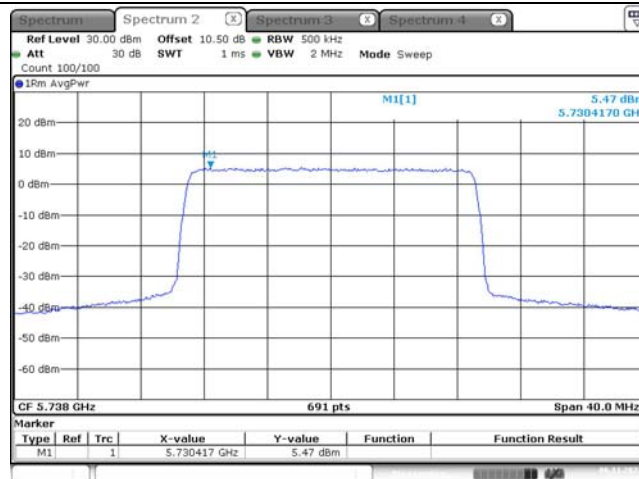
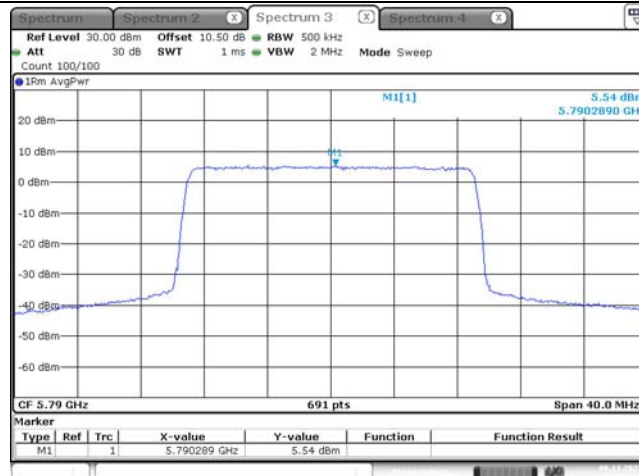
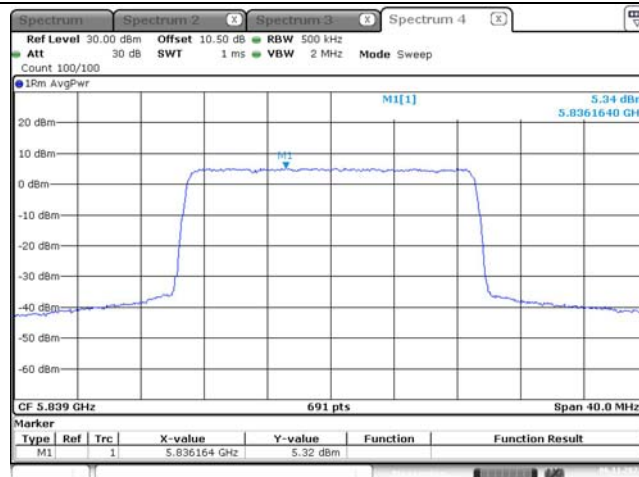
Maximum power spectral density

16QAM,1.4M
Lowest ChannelProjectNo.:CR230955603 Tester:Jim Wei
Date: 6.NOV.2023 14:43:3316QAM,1.4M
Middle ChannelProjectNo.:CR230955603 Tester:Jim Wei
Date: 6.NOV.2023 14:46:4616QAM,1.4M
Highest ChannelProjectNo.:CR230955603 Tester:Jim Wei
Date: 6.NOV.2023 14:48:39

Maximum power spectral density

16QAM,10M
Lowest ChannelProjectNo.:CR230955603 Tester:Jim Wei
Date: 6.NOV.2023 14:54:1716QAM,10M
Middle ChannelProjectNo.:CR230955603 Tester:Jim Wei
Date: 6.NOV.2023 14:53:4616QAM,10M
Highest ChannelProjectNo.:CR230955603 Tester:Jim Wei
Date: 6.NOV.2023 14:51:50

Maximum power spectral density

16QAM,20M
Lowest ChannelProjectNo.:CR230955603 Tester:Jim Wei
Date: 6.NOV.2023 14:59:2016QAM,20M
Highest ChannelProjectNo.:CR230955603 Tester:Jim Wei
Date: 6.NOV.2023 14:59:5416QAM,20M
Middle ChannelProjectNo.:CR230955603 Tester:Jim Wei
Date: 6.NOV.2023 15:02:03

4.6 Duty Cycle:

Serial Number:	2BJM-12	Test Date:	2023/11/06
Test Site:	RF	Test Mode:	Transmitting
Tester:	Jim Wei	Test Result:	N/A

Environmental Conditions:

Temperature: (°C)	25.3	Relative Humidity: (%)	56	ATM Pressure: (kPa)	101.1
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Test Equipment List and Details:

Manufacturer	Description	Model	Serial Number	Calibration Date	Calibration Due Date
R&S	Spectrum Analyzer	FSV40	101474	2023/03/31	2024/03/30
zhuoxiang	Coaxial Cable	SMA-178	211003	Each time	N/A
Mini-Circuits	DC Block	BLK-18-S+	1554403	Each time	N/A
eastsheep	Coaxial Attenuator	2W-SMA-JK-18G	21060301	Each time	N/A

* Statement of Traceability: China Certification ICT Co., Ltd (Dongguan) attests that all calibrations have been performed, traceable to National Primary Standards and International System of Units (SI).

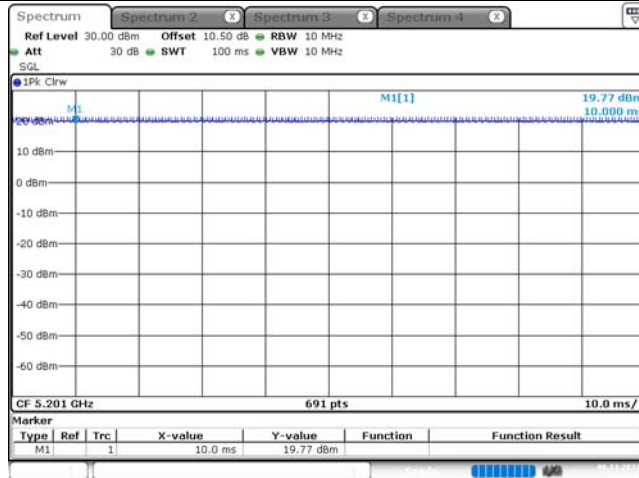
Test Data:

Test only was performed at Chain 0.

Modulation	Test Modes	Ton (ms)	Ton+off (ms)	Duty cycle (%)
QPSK	1.4M	100	100	100.00
	10M	100	100	100.00
	20M	100	100	100.00
16QAM	1.4M	100	100	100.00
	10M	100	100	100.00
	20M	100	100	100.00

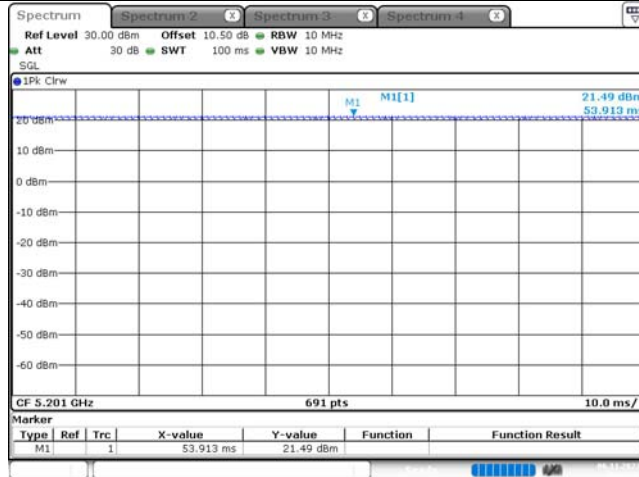
Duty Cycle

QPSK, 1.4M



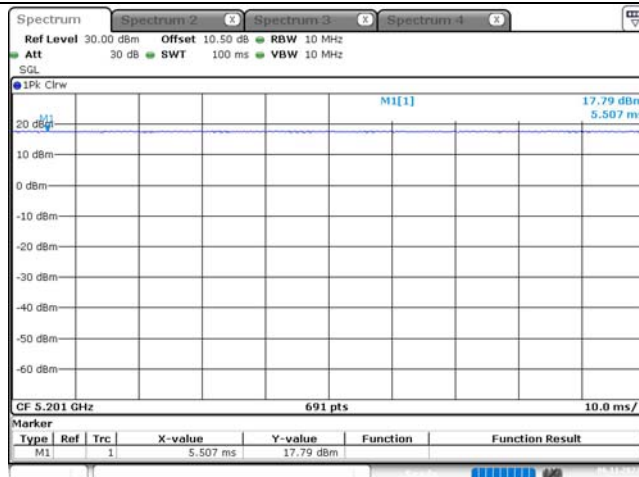
ProjectNo.:CR230955603 Tester:Jim Wei
Date: 6.NOV.2023 15:40:36

QPSK, 10M



ProjectNo.:CR230955603 Tester:Jim Wei
Date: 6.NOV.2023 15:42:33

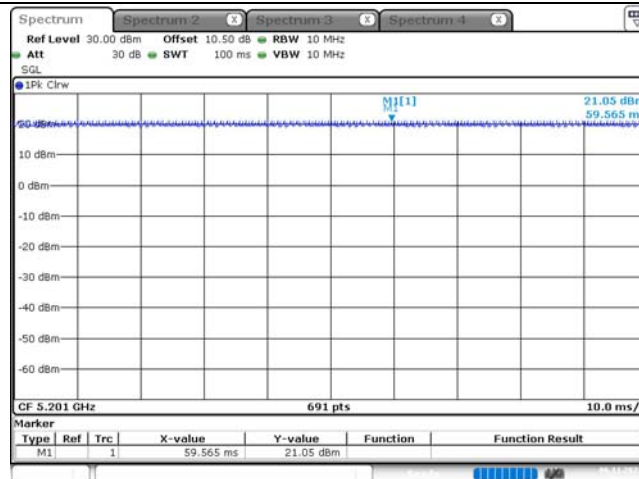
QPSK, 20M



ProjectNo.:CR230955603 Tester:Jim Wei
Date: 6.NOV.2023 15:43:04

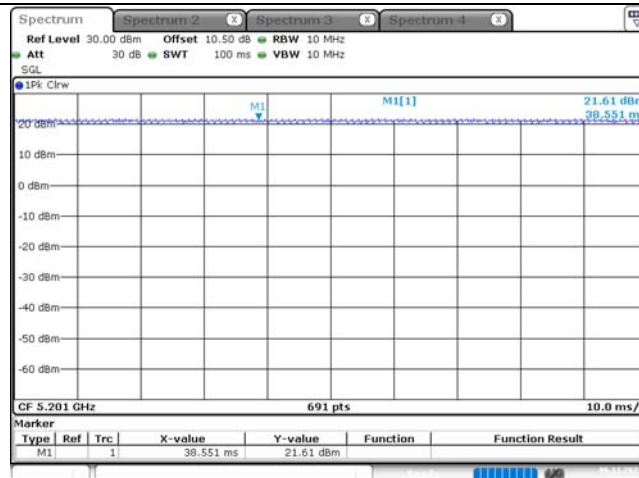
Duty Cycle-16QAM

16QAM,1.4M



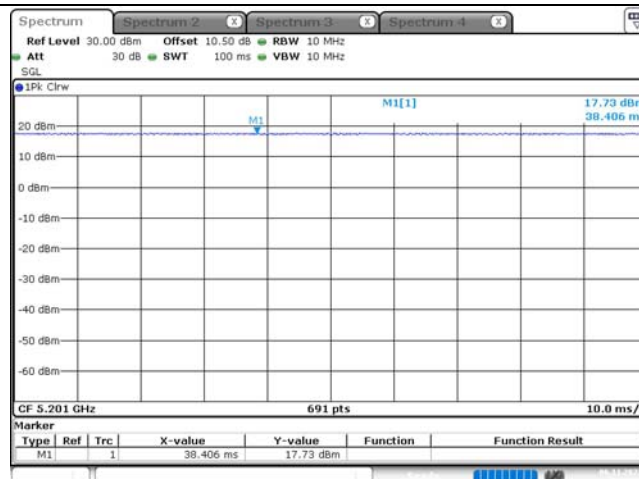
ProjectNo.:CR230955603 Tester:Jim Wei
Date: 6.NOV.2023 15:41:14

16QAM,10M



ProjectNo.:CR230955603 Tester:Jim Wei
Date: 6.NOV.2023 15:42:04

16QAM,20M



ProjectNo.:CR230955603 Tester:Jim Wei
Date: 6.NOV.2023 15:43:34

5. EUT PHOTOGRAPHS

Please refer to the attachment CR230955603-EXP EUT EXTERNAL PHOTOGRAPHS and
CR230955603-INP EUT INTERNAL PHOTOGRAPHS

6. TEST SETUP PHOTOGRAPHS

Please refer to the attachment CR230955603-00F-TSP TEST SETUP PHOTOGRAPHS.

===== END OF REPORT =====